

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/752,667	KIM ET AL.	
Examiner	Art Unit	
Nhon T. Diep	2613	

SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
Interje	rence	Search	History		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventors Search	1/20/06	N.D.		
updated Scarch	1/20/06	N.D		
updated Scarch (included)	' '			
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